

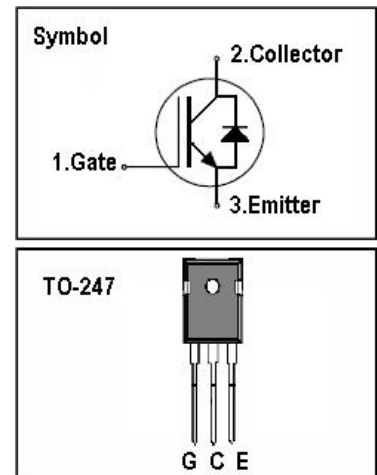


FEATURES

- 650V 50A, $V_{CE(sat)}(typ.) = 1.80\text{ V}@50\text{A}$
- High breakdown voltage up to 650V for improved reliability
- Trench-Stop Technology offering :
 - High speed switching
 - High ruggedness, temperature stable
 - Short circuit withstand time – 5 μs
 - Low V_{CEsat}
 - Easy parallel switching capability due to positive temperature coefficient in V_{CEsat}
- Enhanced avalanche capability

APPLICATION

- Uninterruptible Power Supplies
- Inverter
- Welding Converters
- PFC applications
- Converter with high switching frequency



Maximum Ratings (T_j= 25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Collector-Emitter Breakdown Voltage	V _{CE}	650	V
DC collector current, limited by T _{jmax} T _C = 25°C T _C = 100°C	I _C	100 50	A
Diode Forward current, limited by T _{jmax} T _C = 25°C T _C = 100°C	I _F	80 40	A
Continuous Gate-emitter voltage	V _{GE}	±20	V
Transient Gate-emitter voltage	V _{GE}	±30	V
Turn off safe operating area V _{CE} ≤ 650V, T _j ≤ 175°C, t _p = 1μs	-	150	A
Pulse collector current, V _{GE} = 15V, t _p limited by T _{jmax}	I _{CM}	150	A
Short Circuit Withstand Time, V _{GE} = 15V, V _{CE} ≤ 400V	T _{SC}	5	μs
Power dissipation, T _j = 25°C	P _{tot}	312	W
Operating junction temperature	T _j	-40...+150	°C
Storage temperature	T _S	-55...+150	°C
Soldering temperature, wave soldering 1.6mm (0.063in.) from case for 10s	-	260	°C
Mounting torque, M3 screw Maximum of mounting processes: 3	M	0.6	Nm

Thermal Resistance

Parameter	Symbol	Max. Value	Unit
IGBT thermal resistance, junction - case	R _{θ(j-c)}	0.48	K/W
Diode thermal resistance, junction - case	R _{θ(j-c)}	1.1	K/W
Thermal resistance, junction - ambient	R _{θ(j-a)}	40	K/W

Electrical Characteristics (T_j= 25°C unless otherwise specified)

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Static						
Collector-Emitter Breakdown Voltage	BV _{CES}	V _{GE} =0V, I _C =250uA	650	-	--	V
		V _{GE} =0V, I _C =1mA	650	-	-	V
Gate Threshold Voltage	V _{GE(th)}	V _{GE} =V _{CE} , I _C =250uA	4.0	5.0	6.0	V
Collector-Emitter Saturation Voltage	V _{CE(sat)}	V _{GE} =15V, I _C =50A	-	1.80	2.30	V
		T _j = 25°C T _j = 175°C	-	2.45	-	
Zero gate voltage collector current	I _{CES}	V _{CE} = 650V, V _{GE} = 0V	-	0.1	40	μA
		T _j = 25°C T _j = 175°C	-	-	4000	
Gate-emitter leakage current	I _{GES}	V _{CE} = 0V, V _{GE} = ±20V	-	-	100	nA
Transconductance	g _{fs}	V _{CE} = 20V, I _C = 50A	-	30	-	S

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Dynamic						
Input capacitance	C _{ies}	V _{CE} = 30V, V _{GE} = 0V, f = 1MHz	-	2800	-	pF
Output capacitance	C _{oes}		-	130	-	
Reverse transfer capacitance	C _{res}		-	75	-	
Gate charge	Q _G	V _{CC} = 520V, I _C = 50A, V _{GE} = 15V	-	180	-	nC
Short circuit collector current	I _{C (SC)}	V _{GE} =15V, t _{SC} ≤ 5us V _{CC} =400V, T _{j, start} =25°C	-	310	-	A

Switching Characteristic, Inductive Load

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Dynamic $T_j=25^{\circ}\text{C}$						
Turn-on Delay Time	$t_{d(on)}$	$V_{CC} = 400\text{V}, I_C = 50.0\text{A},$ $V_{GE} = 0.0/15.0\text{V},$ $R_g=12\Omega$	-	40	-	ns
Rise Time	t_r		-	22	-	ns
Turn-off Delay Time	$t_{d(off)}$		-	180	-	ns
Fall Time	t_f		-	88	-	ns
Turn-on Energy	E_{on}		-	1.9	-	mJ
Turn-off Energy	E_{off}		-	1.1	-	mJ

Electrical Characteristics of the DIODE ($T_j=25^{\circ}\text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Dynamic						
Diode Forward Voltage	V_{FM}	$I_F = 40\text{A}$	-	2.3	-	V
Reverse Recovery Time	T_{rr}	$I_F = 40\text{A},$ $V_R = 300\text{V},$ $di/dt = 600\text{A}/\mu\text{s},$	-	90	-	ns
Reverse Recovery Current	I_{rr}		-	17	-	A
Reverse Recovery Charge	Q_{rr}		-	900	-	nC

Typical Performance Characteristics

Fig. 1 FBSOA characteristics

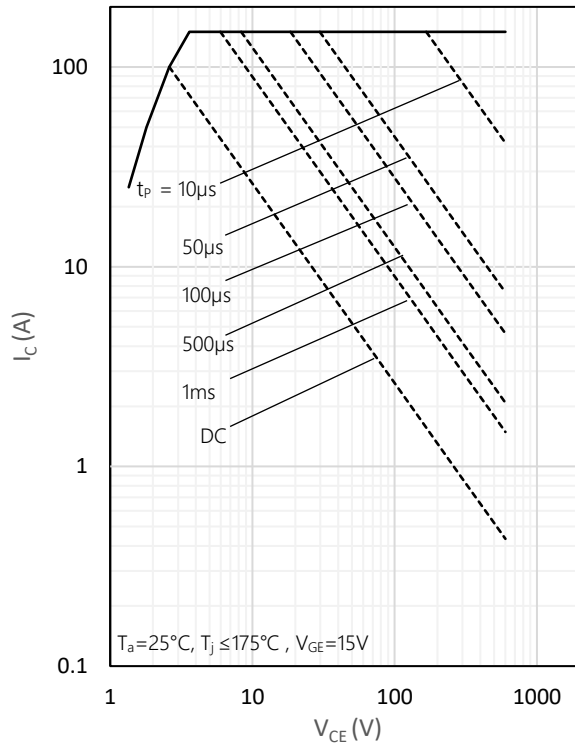


Fig. 2 Load Current vs. Frequency

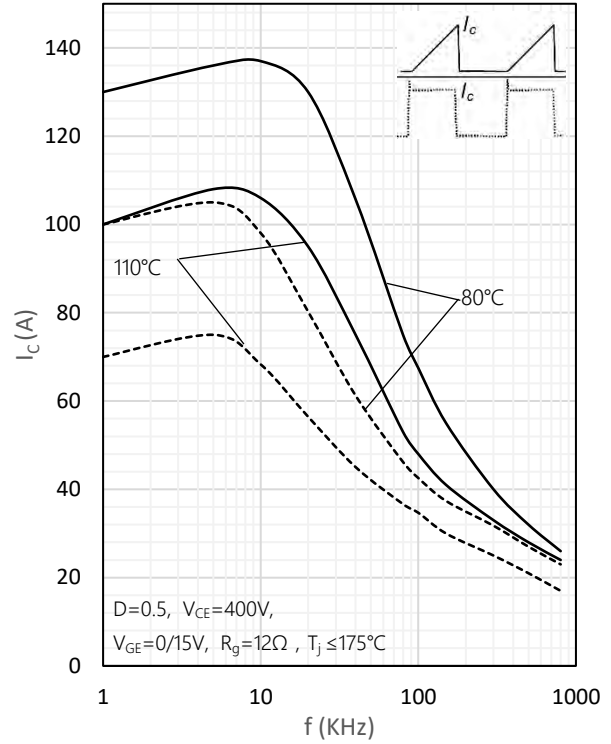


Fig. 3 Output characteristics

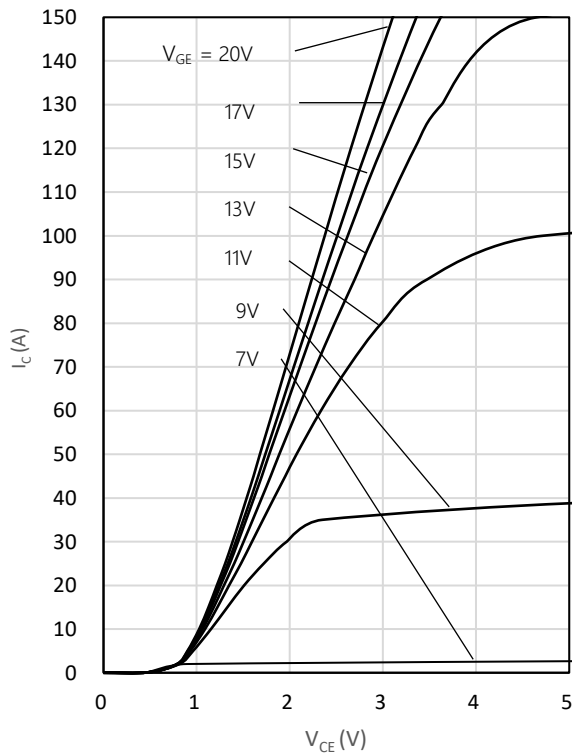


Fig. 4 Saturation voltage characteristics

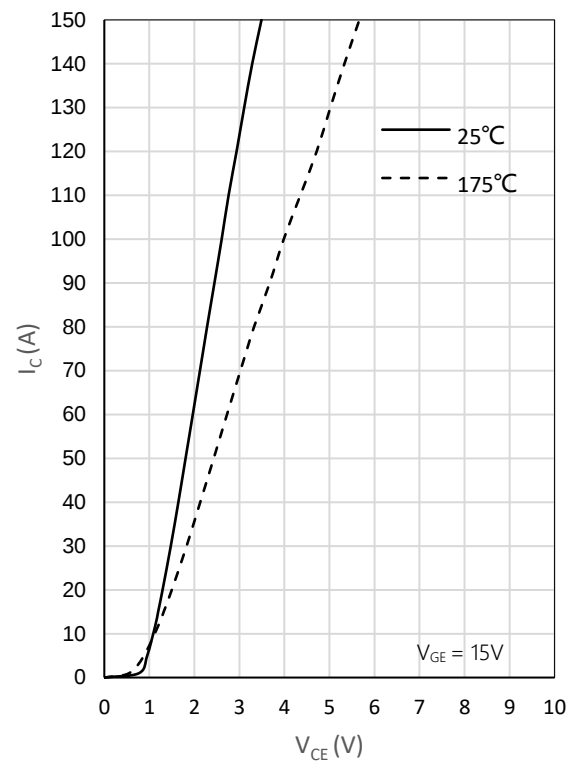


Fig. 5 Switching times vs. gate resistor

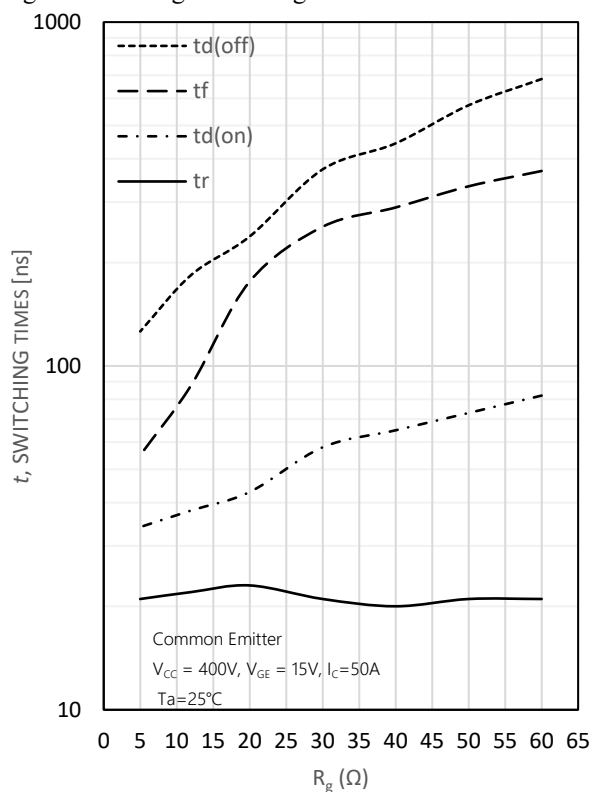


Fig. 6 Switching times vs. collector current

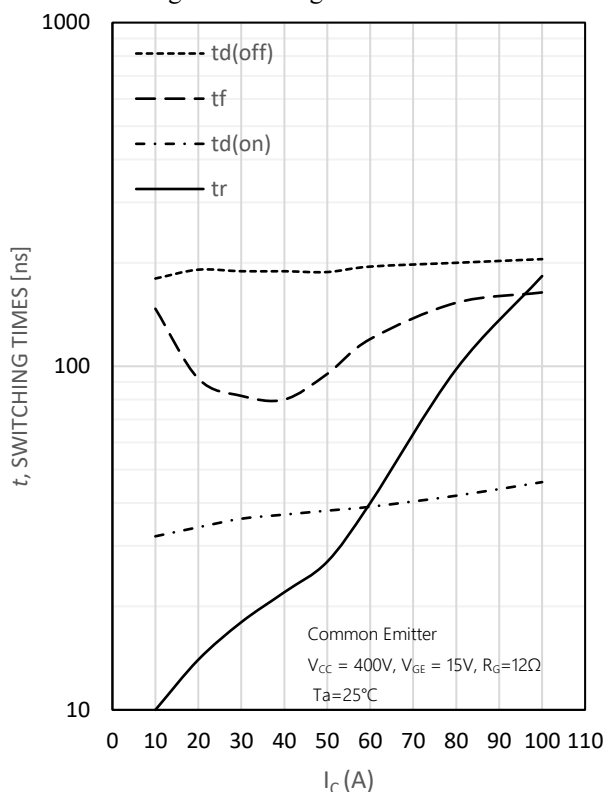


Fig. 7 Switching loss vs. gate resistor

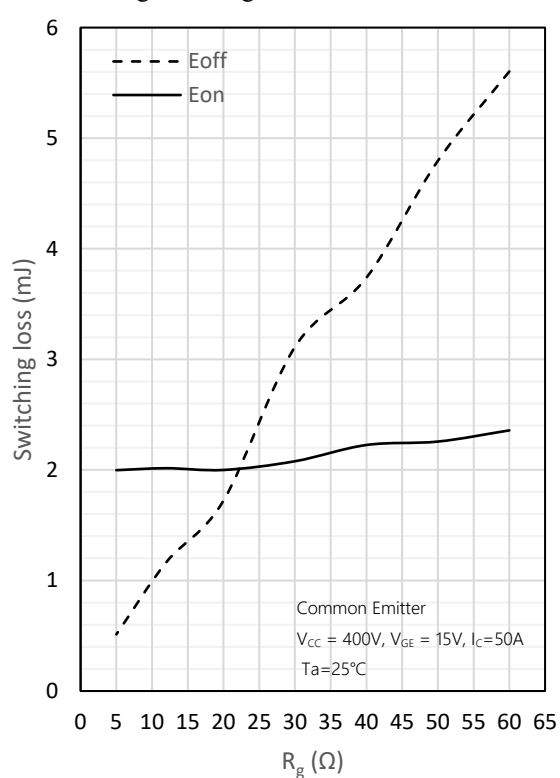


Fig. 8 Switching loss vs. collector current

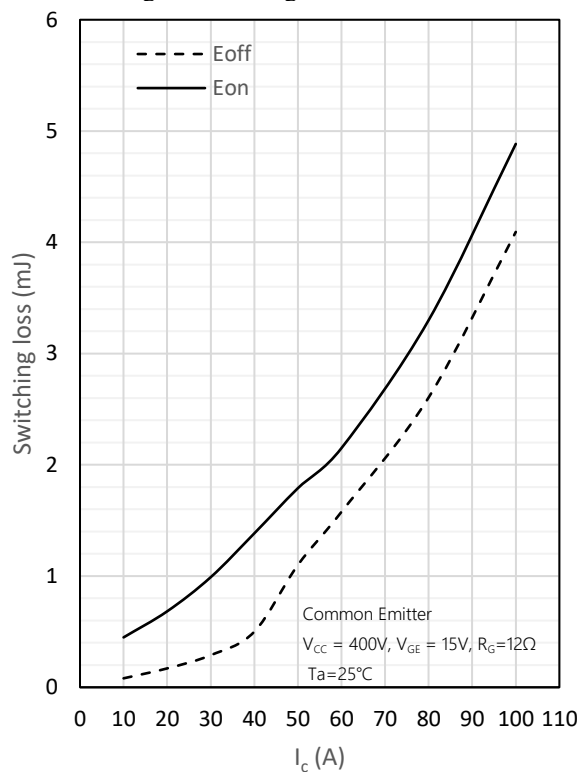


Fig. 9 Gate charge characteristics

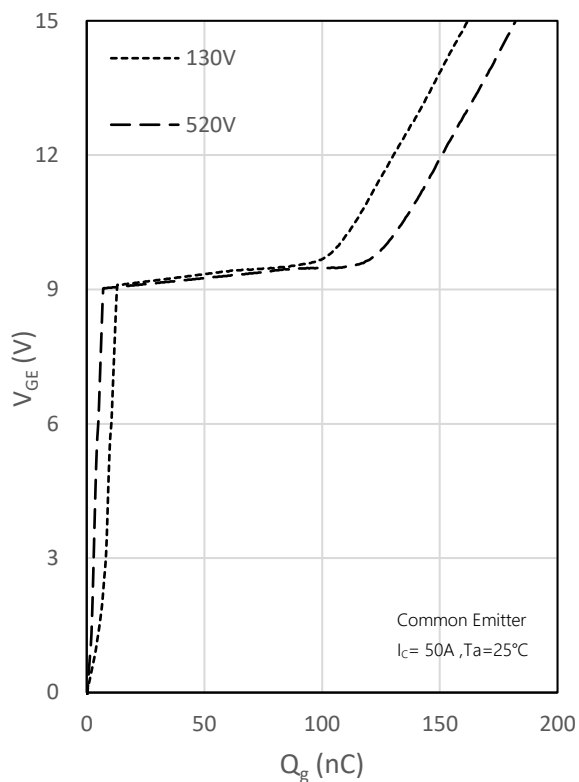
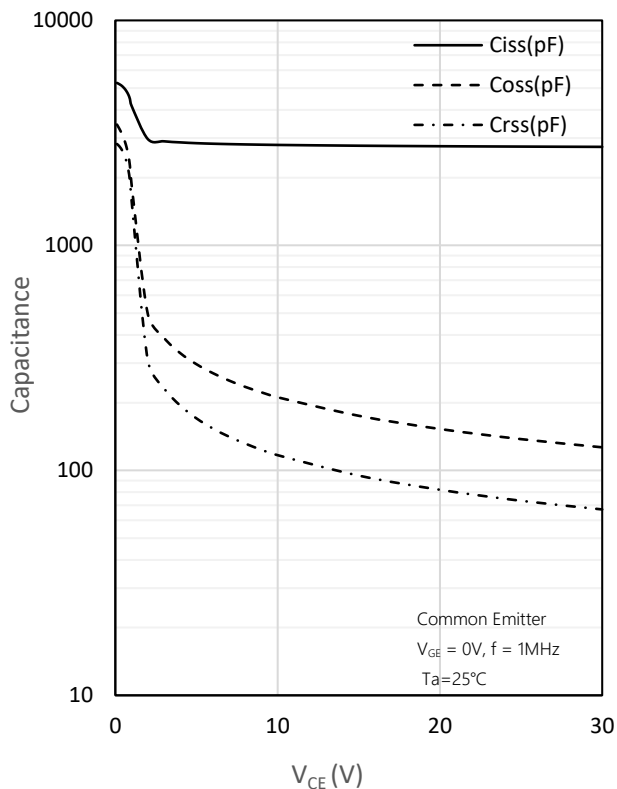
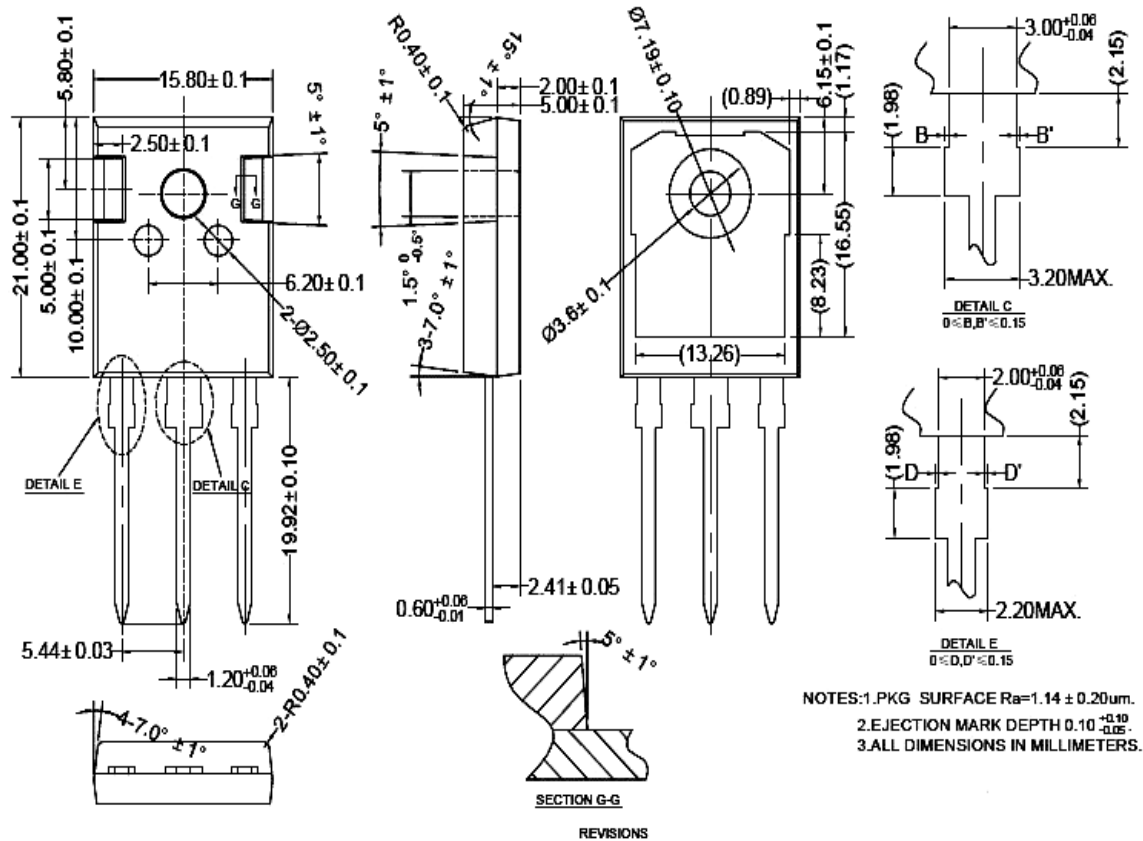


Fig. 10 Capacitance characteristics



TO247 PACKAGE OUTLINE



公差标注	公差值	表面粗糙度
0	±0.2	Ra3.2~6.3
0.0	±0.1	Ra1.6~3.2
0.00	±0.01	Ra0.8~1.6
0.000	±0.005	Ra0.4~0.8
0.0000	±0.002	Ra0.2~0.4

0≤D,D'≤0.15

NOTES: 1.PKG SURFACE Ra=1.14±0.20µm.
2.EJECTION MARK DEPTH 0.10^{+0.10/-0.05}
3.ALL DIMENSIONS IN MILLIMETERS.